

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
650V	$0.28\Omega@10V$	20A

Feature

- Fast Switching
- Low Gate Charge and Rdson
- 100% Single Pulse avalanche energy Test

Application

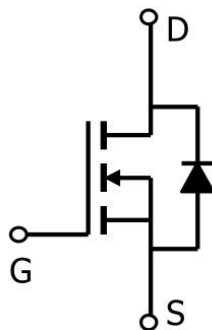
- DC-DC Converter
- Ideal for high-frequency switching and synchronous rectification

Package

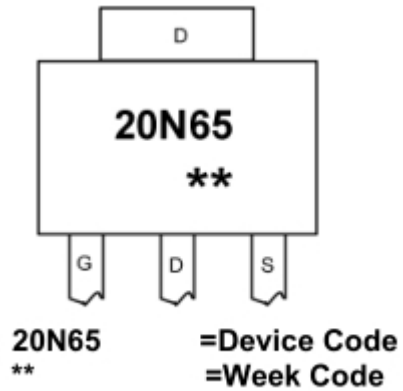


TO-220F(G:1 D:2 S:3)

Circuit diagram



Marking



Absolute maximum ratings

(T_a=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	650	V
Gate-Source Voltage	V _{GS}	±30	V
Continuous Drain Current ¹ (TC=25°C)	I _D	20	A
Pulsed Drain Current ²	I _{DM}	80	A
Single Pulse Avalanche Energy ³	E _{AS}	445	mJ
Total Power Dissipation(TC=25°C)	P _D	85	W
Thermal Resistance Junction-Case ¹	R _{θJC}	1.47	°C/W
Storage Temperature Range	T _{STG}	-55 to 150	°C
Operating Junction Temperature Range	T _J	-55 to 150	°C

Electrical characteristics

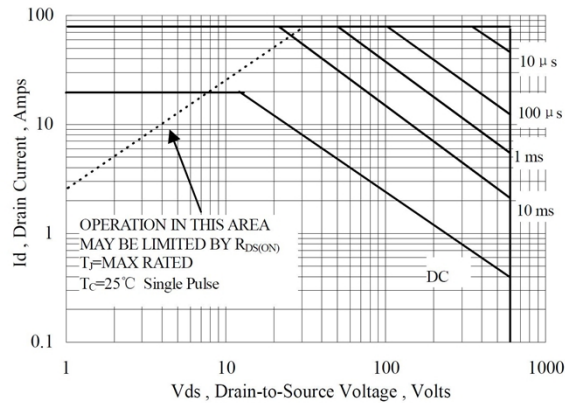
($T_A=25^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	650			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =520V,V _{GS} = 0V, T _J =25°C			1	uA
Gate-body leakage current	I _{GSS}	V _{GS} = ±30V , V _{DS} =0V			±100	uA
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	3	4	5	V
Static Drain-Source On-Resistance ¹	R _{DS(on)}	V _{GS} =10V, I _D =10A		0.28	0.35	mΩ
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz		2431		pF
Output Capacitance	C _{oss}			217		
Reverse Transfer Capacitance	C _{rss}			21		
Switching Characteristics						
Total Gate Charge	Q _g	V _{DS} =325V, V _{GS} =10V, I _D =20A		64		pF
Gate Source Charge	Q _{gs}			13		
Gate Drain Charge	Q _{gd}			24		
Turn-On Delay Time	T _{d(on)}	V _{DD} =325V, V _{GS} =10V, R _G =25Ω, I _D =20A		34		nS
Rise Time	T _r			81		
Turn-Off Delay Time	T _{d(off)}			178		
Fall Time	T _f			93		

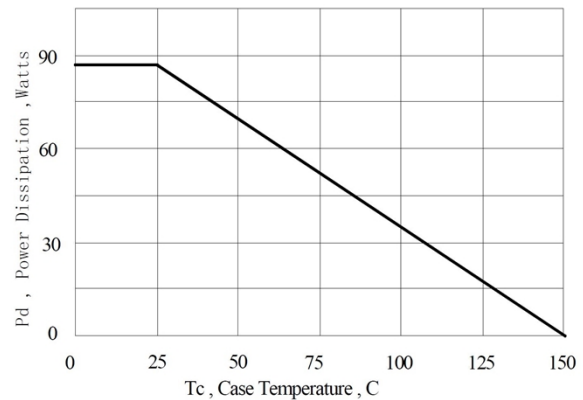
Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $R_G = 30\Omega, L = 10mH$

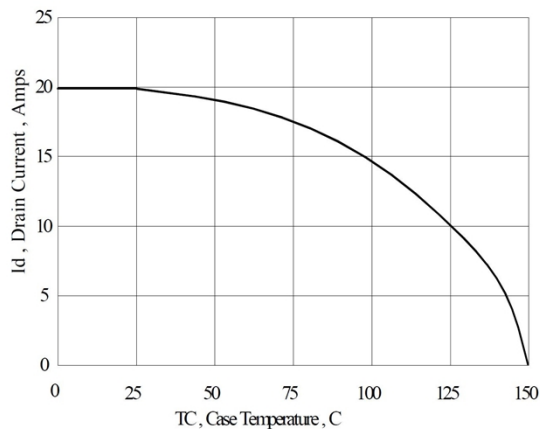
Typical Characteristics



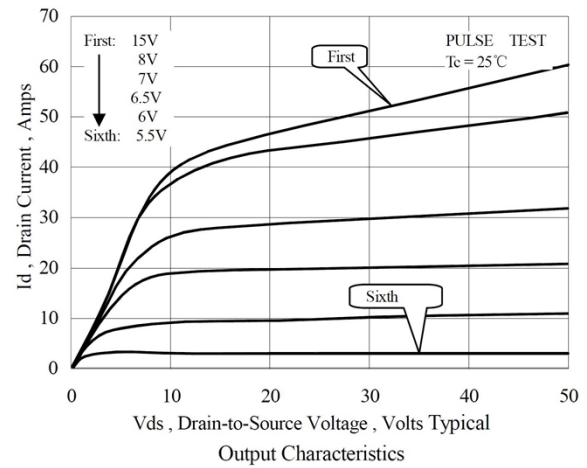
Maximum Forward Bias Safe Operating Area



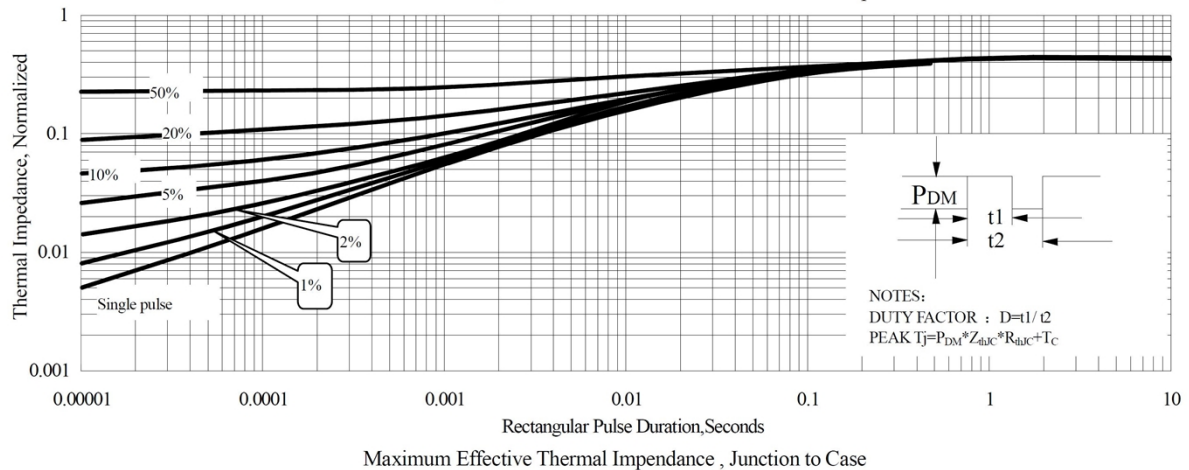
Maximum Power Dissipation vs Case Temperature

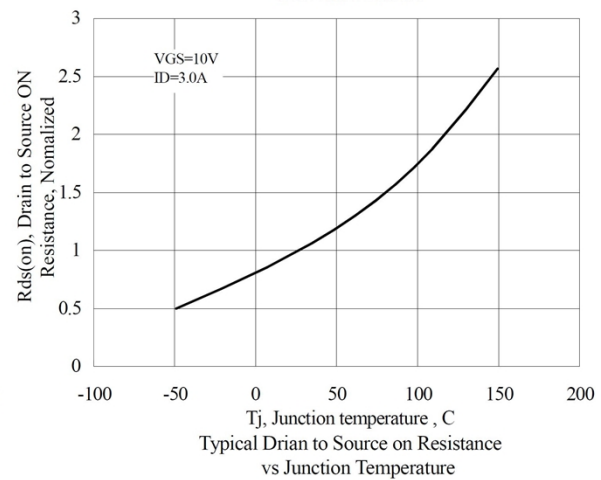
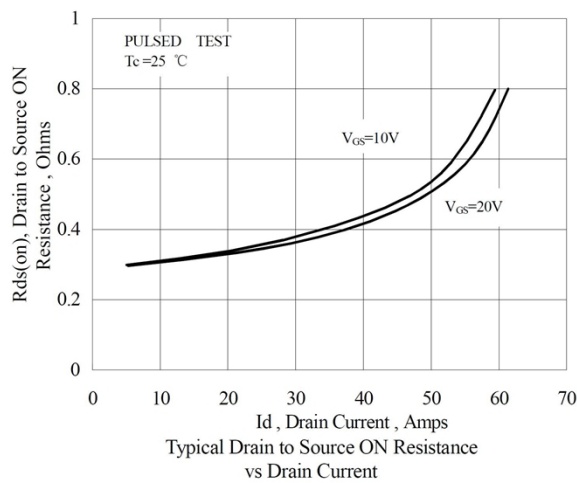
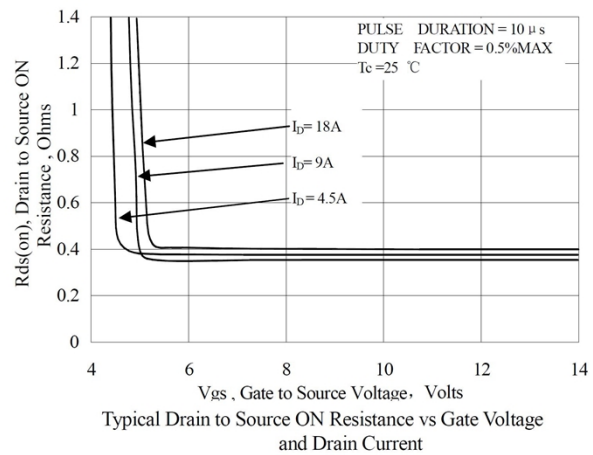
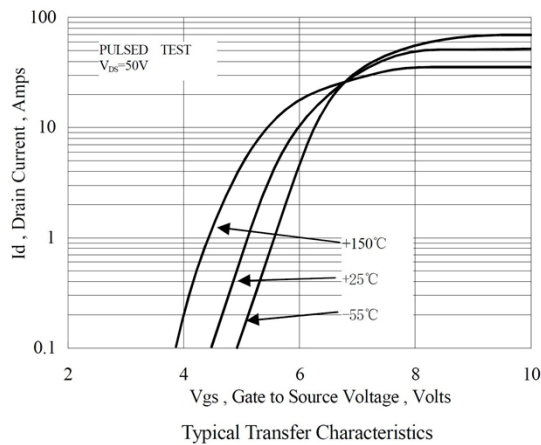
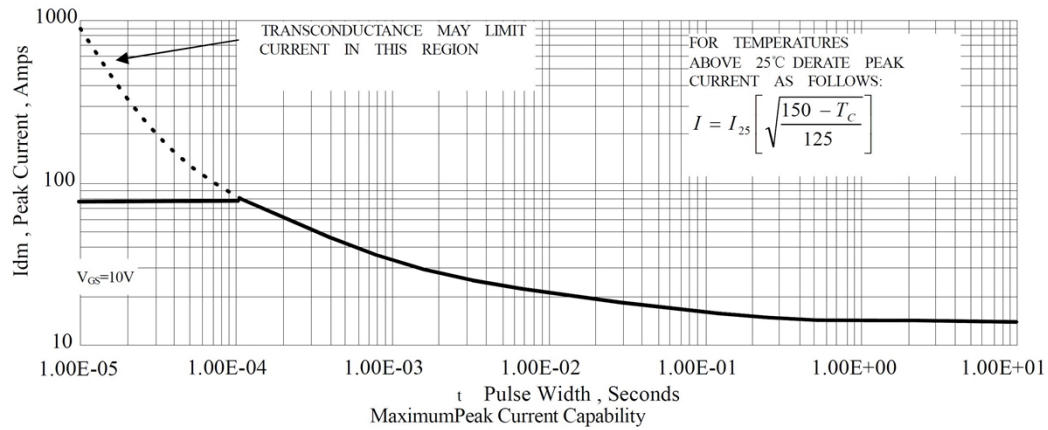


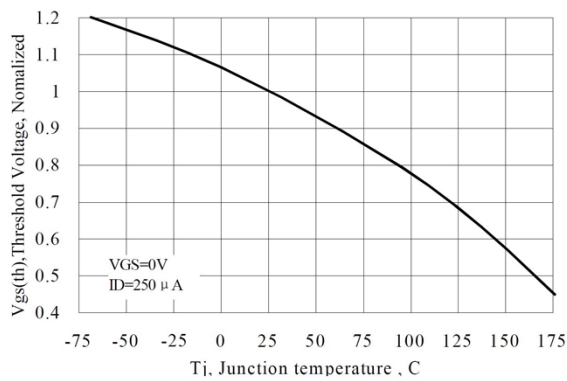
Maximum Continuous Drain Current vs Case Temperature



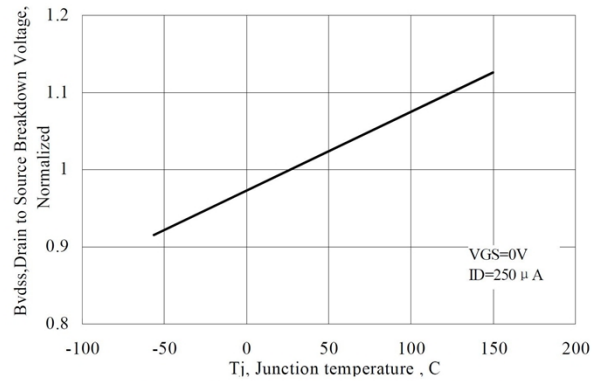
Output Characteristics



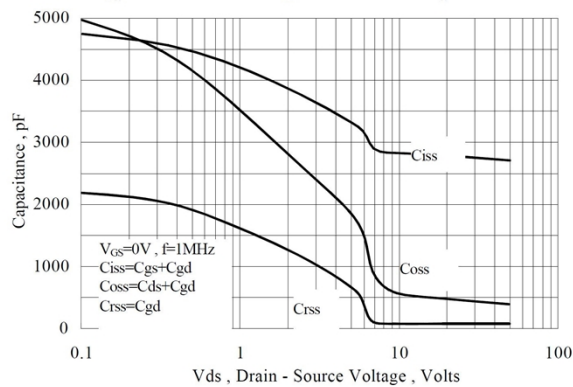




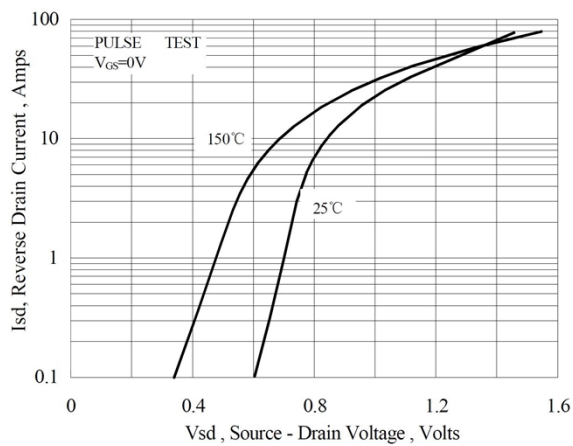
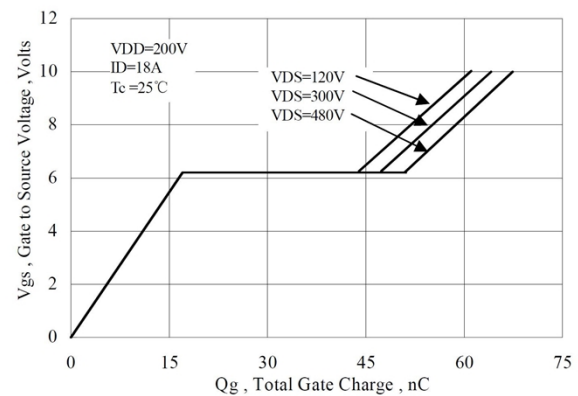
Typical Threshold Voltage vs Junction Temperature



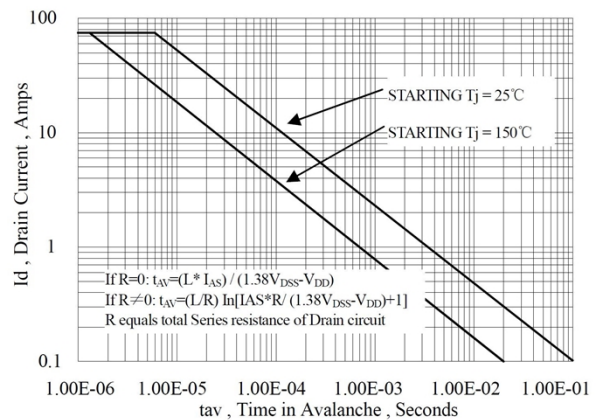
Typical Breakdown Voltage vs Junction Temperature



Typical Capacitance vs Drain to Source Voltage

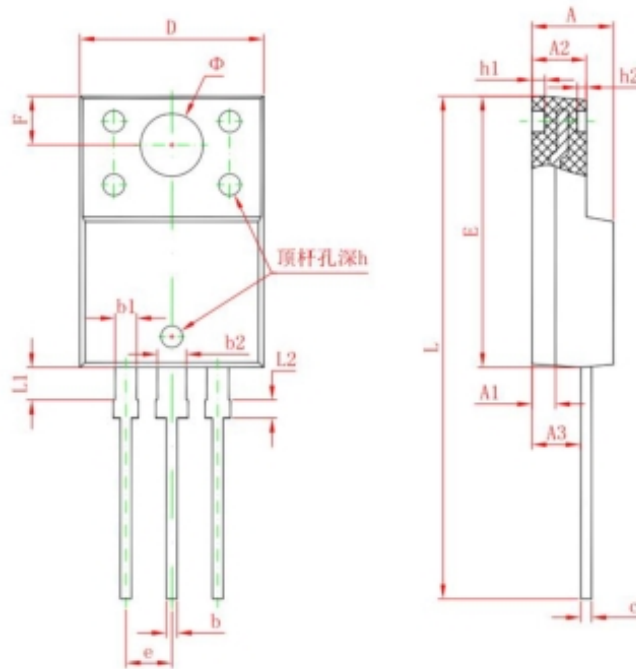


Typical Body Diode Transfer Characteristics



Unclamped Inductive Switching Capability

TO-220F Package Information



Symbol	Dimensions In Millimeters	
	Min.	Max.
A	4.300	4.700
A1	1.300 REF.	
A2	2.800	3.200
A3	2.500	2.900
b	0.500	0.750
b1	1.100	1.350
b2	1.500	1.750
c	0.500	0.750
D	9.960	10.360
E	14.800	15.200
e	2.540 TYP.	
F	2.700 REF.	
Φ	3.500 REF.	
h	0.000	0.300
h1	0.800 REF.	
h2	0.500 REF.	
L	28.000	28.400
L1	1.700	1.900
L2	0.900	1.100